

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/835,366	LAI ET AL.	
Examiner	Art Unit	
LEE NGUYEN	2682	

SEARCHED					
Class	Subclass	Date	Examiner		
455	556.1 556.2 418				
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UPDATE	ALL ABOVE	7/19/2005			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST (US-PGPUB, USPAT, USOCR, EPO, JPO, DERWENT, IBM) SEE SEARCH NOTE	7/19/2005	LN .		
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